

Notice of References Cited			Application/Control No.	Applicant(s)/Patent Under Reexamination 10/553,180 UCHIDA ET AL.	
			Examiner	Art Unit Helen C. Kwok	2856 Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,774,977	08-2004	Walton et al.	349/177
*	B	US-6,266,109	07-2001	Yamaguchi et al.	349/86
*	C	US-6,885,412	04-2005	Ohnishi et al.	349/72
*	D	US-7,154,463	12-2006	Kwag, Jin-Oh	345/94
*	E	US-7,084,939	08-2006	Paukshto et al.	349/101
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2004-20255	01-2004	Japan	Yanai et al.	---
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.